

Search Notes



Application No.

10/624,466

Examiner

Sang Y Paik

Applicant(s)

HARWELL ET AL

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	482 483 486		
	487		
	484		
	490		
	492		
	448.12		
	448.13		
	460.1		
	465.1	9/2/04	2
Updated as	active	3/9/05	8

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
ENT TEST SEARCHED	9/2/04 3/9/05	2P 8

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